

Application/Control	No.
Application/Control 10/644,782	

KANEKO ET AL.

Reexamination

Applicant(s)/Patent under

Examiner

John P. Sheehan

Art Unit

																· · ·				
];	SSU	E C	LAS	SIF	CAT	ION	J							
			ORI	GINAL							IN	TERNA	TIONAL	L CLAS	SIFICA1	ION			_,	
CLASS SUBCLASS								CLAIMED						NON-CLAIMED						
148 101						н	01	F	1	/	/053		01	F 1		/057				
		CR	OSS RI	EFEREN	ICES							,								
CLASS SUBCLASS (ONE SUBCLASS PER BLOCK)												,								
148		302	302									1	1				/			
164	4	463									1	•				"	1			
												1							•	
												1								
									1			1					-	1	`	
		100										Т	·		•					
									Total							Claims Allowed: 11				
	(Assis	tant Exa	miner)	(Da	ate)	_	,	John F	P. She	eehan		ļ						T		
(Nago) 1 5/2/16 100mm						ırv Evam	Examiner) (Date)					O.G. Print Claim(s)				O.G. Print Fig.				
(Legal Instruments Examiner) (Date) (Primary						0	~ 0.0					4								
							49 me		Kele	-4	28/4	4			1			-	5	
Claims renumbered in the same order as pre							resen	ented by applicant						⊠⊤	.D.		☐ R.1.47			
<u></u>	nal		<u>m</u>	nal			nai		<u></u>	nal			nal			nal		<u></u>	Jai	
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original	
1		-																	-	
2	2	 		31 32			61 62			91 92	 		121 122		}	151 152			18:	
3	3	1		33			63			93	1		123		}	153			183	
4	4			34			64			94			124			154			184	
5	5			35			65			95	ļ [125			155			18	
6 7	7	┨		36 37			66			96 97	{		126			156			18	
8	8	 		38			68			98	 		127 128	l		157 158	1		18 18	
9	9	1		39			69			99			129			159			18	
10	10			40			70			100			130			160			19	
11	11	_		41			71			101	[131			161			19	
	12	-		42			72			102	}		132			162			19	
	13 14		-	43 44			73 74			103		- 1	133			163 164	1	1	19 19	
	15	1 1		45			75			104			135			165			19	
	16	1		46			76			106			136			166			19	
	17			47	0		77			107			137			167			19	
	18			48			78			108			138			168			19	
	19] [49			79			109			139			169			19	